

**Search Notes**

Application/Control No.

10/788,765

Examiner

Tianjie Chen

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
360	324.11		
	324.12		
	327.3		
	327.31		
	327.32	2/12/2009	TJ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
360	324.11	2/12/2009	TJ

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Report	2/12/2009	TJ